

RoHS

HY65R381MF-VB Datasheet

N-Channel 650V (D-S) Super Junction Power MOSFET

PRODUCT SUMMARY					
V_{DS} (V) at T_J max.	650				
R _{DS(on)} at 25 °C (Ω)	$V_{GS} = 10 V$	0.42			
Q _g max. (nC)	38				
Q _{gs} (nC)	4				
Q _{gd} (nC)	4.2				
Configuration	Single				

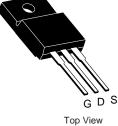
FEATURES

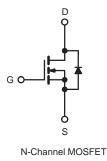
- Low figure-of-merit (FOM) Ron x Qg
- Low input capacitance (C_{iss})
- · Reduced switching and conduction losses
- Ultra low gate charge (Q_q)
- Avalanche energy rated (UIS)

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial







ABSOLUTE MAXIMUM RATINGS (T _C :	= 25 °C, unl	less otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	650	N/	
Gate-Source Voltage			V _{GS}	± 30	V	
	V -+ 10 V	T _C = 25 °C		11		
Continuous Drain Current (T _J = 150 °C)	V _{GS} at 10 V	$T_{\rm C} = 25 \ ^{\circ}{\rm C}$ $T_{\rm C} = 100 \ ^{\circ}{\rm C}$	ID	9.7	А	
Pulsed Drain Current ^a			I _{DM}	55		
Linear Derating Factor				1.67/1.5/0.3	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	132	mJ	
Maximum Power Dissipation			PD	83/83/31	W	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C	
Drain-Source Voltage Slope $T_J = 125 \text{ °C}$		-11/1	50			
Reverse Diode dV/dt ^d			dV/dt	3.1	V/ns	
Soldering Recommendations (Peak Temperature) ^c	for	10 s		300	°C	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature. b. $V_{DD} = 50$ V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 4.5 A.

c. 1.6 mm from case.

d. $I_{SD} \leq I_D$, dI/dt = 100 A/µs, starting T_J = 25 °C.



THERMAL RESISTANCE RATI	NGS							
PARAMETER	SYMBOL	TYP.		MAX.			UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-		60		0000		
Maximum Junction-to-Case (Drain)	R _{thJC}	-		0.6			°C/W	
SPECIFICATIONS (T _J = 25 $^{\circ}$ C, u	nless otherwi	se noted)						
PARAMETER	SYMBOL	TES	T CONDIT	IONS	MIN.	TYP.	MAX.	UNIT
Static		•			•			
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D =	250 µA	650	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	$I_D = 1 \text{ mA}$	-	0.65	-	V/°C
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D =	250 µA	2	-	4	V
	_	,	$V_{GS} = \pm 20$	V	-	-	± 100	nA
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 30	V	-	-	± 1	μA
	$V_{DS} = 650 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	-	-	1				
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 520 V, V _{GS} = 0 V, T _J = 125 °C		-	-	10	μA	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V		I _D = 5 A	-	0.42	-	Ω
Forward Transconductance	g fs	V _{DS}	= 30 V, I _D	= 5 A	-	16	-	S
Dynamic		•						
Input Capacitance	C _{iss}		$V_{cc} = 0.$	/	-	680	-	
Output Capacitance	Coss	V _{GS} = 0 V, V _{DS} = 100 V, f = 1 MHz		-	140	-		
Reverse Transfer Capacitance	C _{rss}			-	5	-		
Effective Output Capacitance, Energy Related ^a	C _{o(er)}	$- \frac{1}{113} = 1 \text{ Win} 2 - \frac{5}{5}$ $- \frac{5}{63} - \frac{63}{113}$		-	pF			
Effective Output Capacitance, Time Related ^b	C _{o(tr)}			-	113	-		
Total Gate Charge	Qg				-	38	56	
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 V$	I _D = 5 /	A, V _{DS} = 520 V	-	4	-	nC
Gate-Drain Charge	Q _{gd}				-	4.5	-	
Turn-On Delay Time	t _{d(on)}				-	13	25	
Rise Time	t _r	$\begin{array}{c c c c c c c c c c c c c c c c c c c $			ns			
Turn-Off Delay Time	t _{d(off)}							
Fall Time	t _f					40		
Gate Input Resistance	Rg	T = 1	winz, ope	n drain	-	3.5	-	Ω
Drain-Source Body Diode Characteristic	S	T						
Continuous Source-Drain Diode Current	۱ _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	11	А	
Pulsed Diode Forward Current	I _{SM}			-	-	55		
Diode Forward Voltage	V _{SD}	T _J = 25 °C, I _S = 5 A, V _{GS} = 0 V		-	-	1.5	V	
Reverse Recovery Time	t _{rr}				-	270	-	ns
Reverse Recovery Charge	Q _{rr}	$T_{J} = 2$	$5 \circ C, I_F = 1$	$I_{\rm S} = 5 {\rm A},$	-	3.3	-	μC
Reverse Recovery Current	I _{RRM}	ai/at = 1	ιου Α/μs, \	/ _R = 400 V	-	30	_	A

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

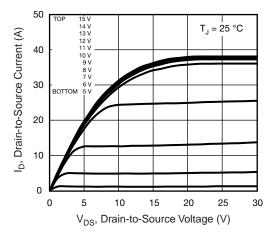


Fig. 1 - Typical Output Characteristics

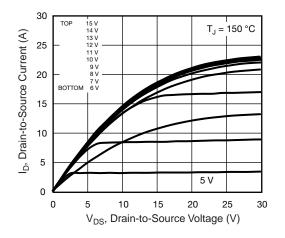


Fig. 2 - Typical Output Characteristics

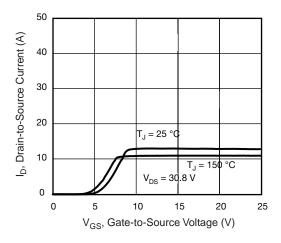


Fig. 3 - Typical Transfer Characteristics

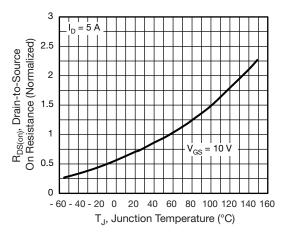


Fig. 4 - Normalized On-Resistance vs. Temperature

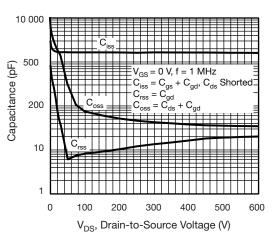


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

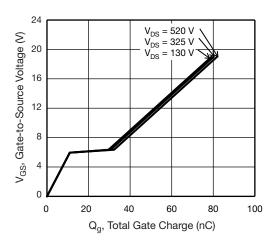


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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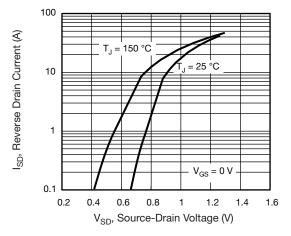
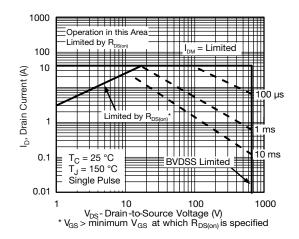


Fig. 7 - Typical Source-Drain Diode Forward Voltage





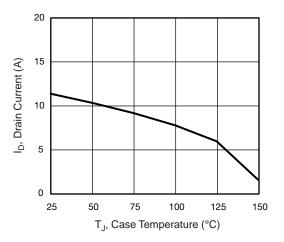


Fig. 9 - Maximum Drain Current vs. Case Temperature

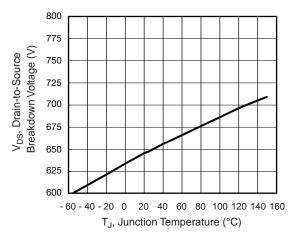


Fig. 10 - Temperature vs. Drain-to-Source Voltage

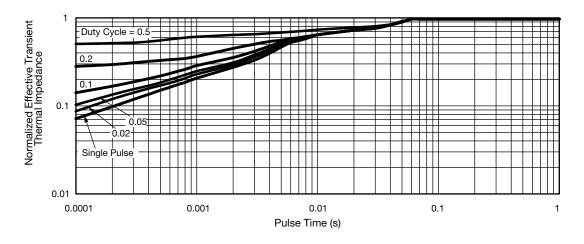


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



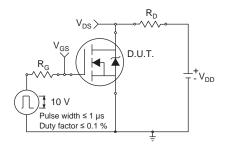


Fig. 12 - Switching Time Test Circuit

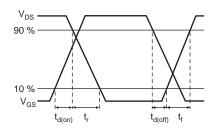


Fig. 13 - Switching Time Waveforms

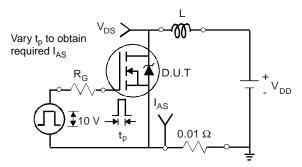


Fig. 14 - Unclamped Inductive Test Circuit

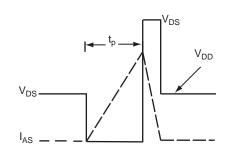


Fig. 15 - Unclamped Inductive Waveforms

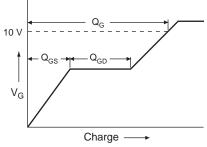


Fig. 16 - Basic Gate Charge Waveform

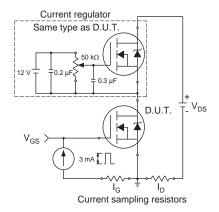
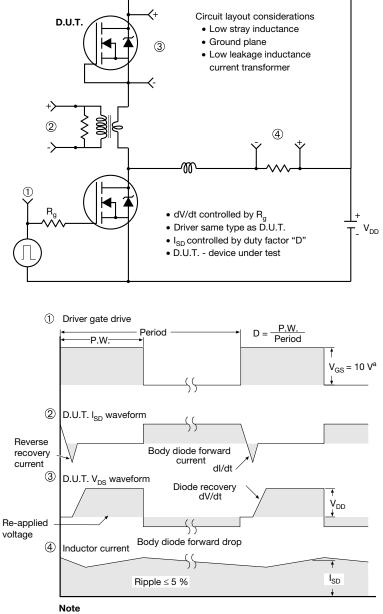


Fig. 17 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



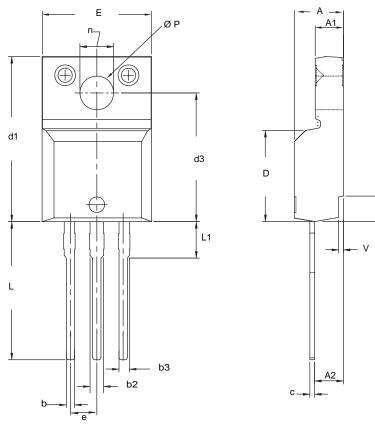
a. $V_{GS} = 5$ V for logic level devices

Fig. 18 - For N-Channel



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TO-220 FULLPAK (HIGH VOLTAGE)



	MILLI	METERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
А	4.570	4.830	0.180	0.190
A1	2.570	2.830	0.101	0.111
A2	2.510	2.850	0.099	0.112
b	0.622	0.890	0.024	0.035
b2	1.229	1.400	0.048	0.055
b3	1.229	1.400	0.048	0.055
С	0.440	0.629	0.017	0.025
D	8.650	9.800	0.341	0.386
d1	15.88	16.120	0.622	0.635
d3	12.300	12.920	0.484	0.509
E	10.360	10.630	0.408	0.419
е	2.54	BSC	0.100 BSC	
L	13.200	13.730	0.520	0.541
L1	3.100	3.500	0.122	0.138
n	6.050	6.150	0.238	0.242
ØP	3.050	3.450	0.120	0.136
u	2.400	2.500	0.094	0.098
V	0.400	0.500	0.016	0.020

Notes

1. To be used only for process drawing. 2. These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads. 3. All critical dimensions should C meet $C_{pk} > 1.33$. 4. All dimensions include burrs and plating thickness.

5. No chipping or package damage.



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